

## MOS FIELD EFFECT TRANSISTOR

# 2SK3480

### SWITCHING N-CHANNEL POWER MOS FET

#### DESCRIPTION

The 2SK3480 is N-channel MOS Field Effect Transistor designed for high current switching applications.

#### FEATURES

- Super low on-state resistance:
- $R_{DS(on)1} = 31 \text{ m}\Omega \text{ MAX.} (V_{GS} = 10 \text{ V}, \text{ ID} = 25 \text{ A})$
- $R_{\text{DS(on)2}}$  = 36 m $\Omega$  MAX. (VGs = 4.5 V, ID = 25 A)
- Low Ciss:  $C_{iss} = 3600 \, pF \, TYP$ .
- Built-in gate protection diode

#### ABSOLUTE MAXIMUM RATINGS (TA = 25°C)

| Drain to Source Voltage (Vgs = 0 V)             | Vdss        | 100         | V  |
|---|-------------|-------------|----|
| Gate to Source Voltage (VDS = 0 V)              | Vgss        | ±20         | V  |
| Drain Current (DC) (Tc = 25°C)                  | D(DC)       | ±50         | А  |
| Drain Current (pulse) Note1                     | D(pulse)    | ±100        | А  |
| Total Power Dissipation (Tc = 25°C)             | <b>P</b> T1 | 84          | W  |
| Total Power Dissipation ( $T_A = 25^{\circ}C$ ) | <b>P</b> T2 | 1.5         | W  |
| Channel Temperature                             | Tch         | 150         | °C |
| Storage Temperature                             | Tstg        | -55 to +150 | °C |
| Single Avalanche Current Note2                  | las         | 34          | А  |
| Single Avalanche Energy <sup>Note2</sup>        | Eas         | 116         | mJ |
|   |             |             |    |

**Notes 1.** PW  $\leq$  10  $\mu$ s, Duty cycle  $\leq$  1%

**2.** Starting T<sub>ch</sub> = 25°C, R<sub>G</sub> = 25  $\Omega$ , V<sub>GS</sub> = 20  $\rightarrow$  0 V

#### THERMAL RESISTANCE

| Channel to Case    | Rth(ch-C) | 1.48 | °C/W |
|--------------------|-----------|------|------|
| Channel to Ambient | Rth(ch-A) | 83.3 | °C/W |

#### ORDERING INFORMATION

| PART NUMBER | PACKAGE                   |
|-------------|---------------------------|
| 2SK3480     | TO-220AB                  |
| 2SK3480-S   | TO-262                    |
| 2SK3480-ZJ  | TO-263                    |
| 2SK3480-Z   | TO-220SMD <sup>Note</sup> |

Note TO-220SMD package is produced only in Japan.

(TO-220AB)



(TO-262)



(TO-263, TO-220SMD)



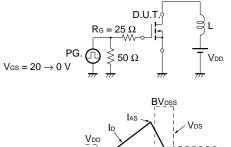
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ELECTRICAL CHARACTERISTICS (TA = 25°C)

| CHARACTERISTICS                     | SYMBOL               | TEST CONDITIONS                               | MIN. | TYP. | MAX. | UNIT |
|-------------------------------------|----------------------|---|------|------|------|------|
| Zero Gate Voltage Drain Current     | IDSS                 | $V_{DS} = 100 V, V_{GS} = 0 V$                |      |      | 10   | μA   |
| Gate Leakage Current                | lgss                 | $V_{GS} = \pm 20 V, V_{DS} = 0 V$             |      |      | ±10  | μA   |
| Gate Cut-off Voltage                | V <sub>GS(off)</sub> | $V_{DS} = 10 V, I_D = 1 mA$                   | 1.5  | 2.0  | 2.5  | V    |
| Forward Transfer Admittance         | y <sub>fs</sub>      | $V_{DS} = 10 V, I_D = 25 A$                   | 17   | 34   |      | S    |
| Drain to Source On-state Resistance | RDS(on)1             | $V_{GS} = 10 V$ , $I_D = 25 A$                |      | 25   | 31   | mΩ   |
|                                     | RDS(on)2             | $V_{GS} = 4.5 V, I_D = 25 A$                  |      | 27   | 36   | mΩ   |
| Input Capacitance                   | Ciss                 | V <sub>DS</sub> = 10 V                        |      | 3600 |      | pF   |
| Output Capacitance                  | Coss                 | V <sub>GS</sub> = 0 V                         |      | 360  |      | pF   |
| Reverse Transfer Capacitance        | Crss                 | f = 1 MHz                                     |      | 190  |      | pF   |
| Turn-on Delay Time                  | td(on)               | V <sub>DD</sub> = 50 V, I <sub>D</sub> = 25 A |      | 15   |      | ns   |
| Rise Time                           | tr                   | V <sub>GS</sub> = 10 V                        |      | 11   |      | ns   |
| Turn-off Delay Time                 | td(off)              | $R_G = 0 \Omega$                              |      | 68   |      | ns   |
| Fall Time                           | tr                   |   |      | 6.0  |      | ns   |
| Total Gate Charge                   | QG                   | V <sub>DD</sub> = 80 V                        |      | 74   |      | nC   |
| Gate to Source Charge               | QGS                  | Vgs = 10 V                                    |      | 10   |      | nC   |
| Gate to Drain Charge                | Qgd                  | ID = 50 A                                     |      | 20   |      | nC   |
| Body Diode Forward Voltage          | VF(S-D)              | IF = 50 A, VGS = 0 V                          |      | 1.0  |      | V    |
| Reverse Recovery Time               | trr                  | IF = 50 A, VGS = 0 V                          |      | 70   |      | ns   |
| Reverse Recovery Charge             | Qrr                  | di/dt = 100 A/µs                              |      | 180  |      | nC   |

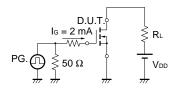
#### TEST CIRCUIT 1 AVALANCHE CAPABILITY

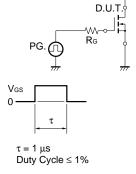
#### **TEST CIRCUIT 2 SWITCHING TIME**

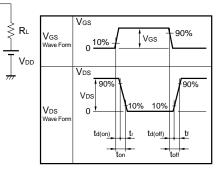




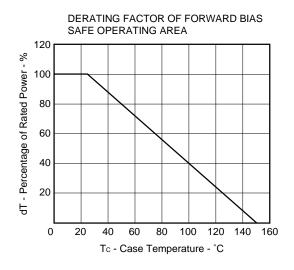
#### TEST CIRCUIT 3 GATE CHARGE



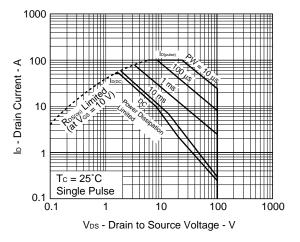


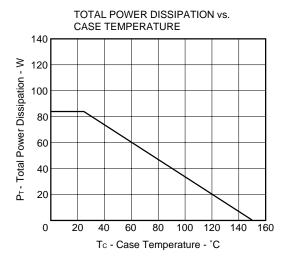


#### TYPICAL CHARACTERISTICS (TA = 25°C)

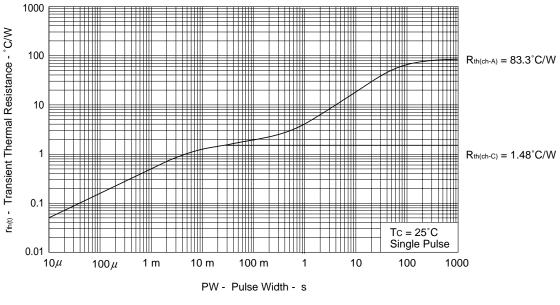


FORWARD BIAS SAFE OPERATING AREA

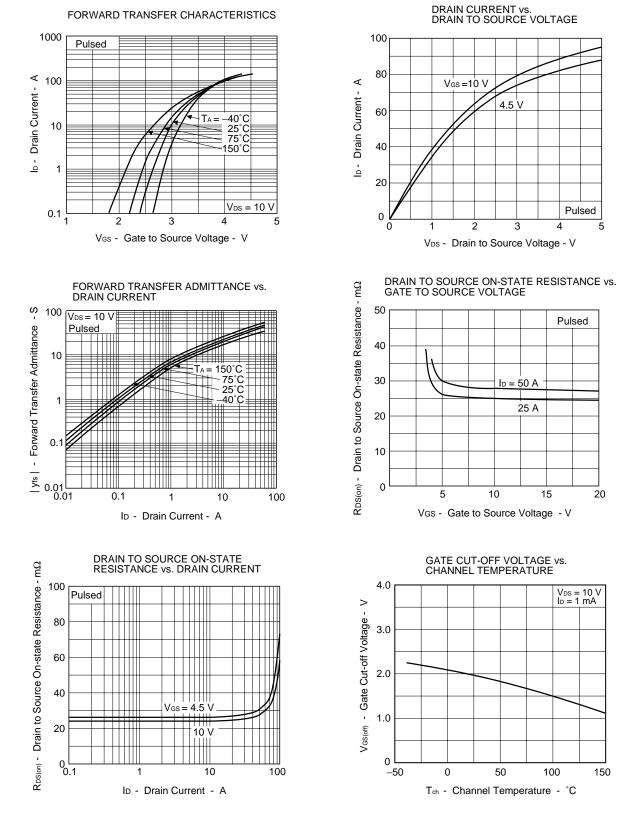




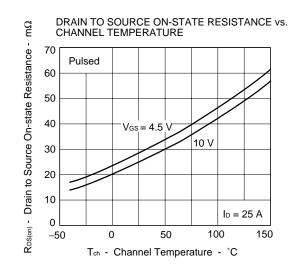
TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH

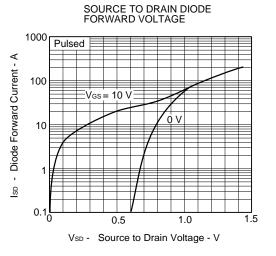


Data Sheet D15078EJ1V0DS

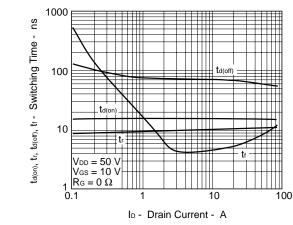


FORWARD TRANSFER CHARACTERISTICS





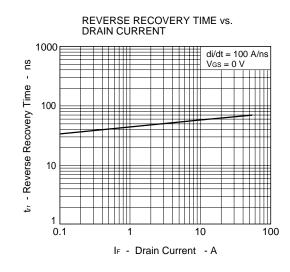
SWITCHING CHARACTERISTICS



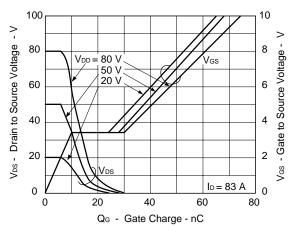
10000 <u>₽</u> Ciss, Coss, Crss - Capacitance - pF Ciss 1000 100 Vgs = 0 V f = 1 MHz10 0.01 0.1 1 10 100 VDS - Drain to Source Voltage - V

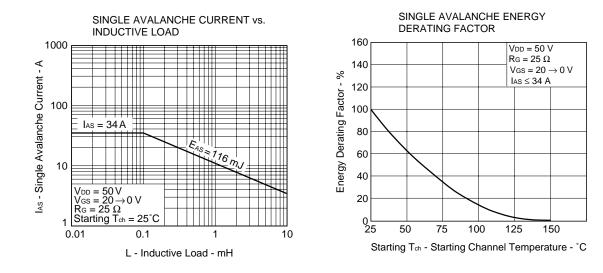
CAPACITANCE vs.

DRAIN TO SOURCE VOLTAGE



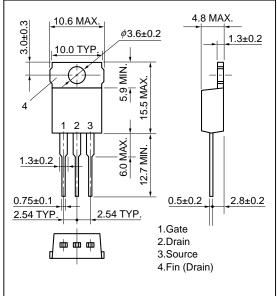
DYNAMIC INPUT/OUTPUT CHARACTERISTICS



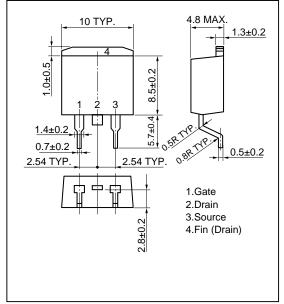


#### PACKAGE DRAWINGS (Unit: mm)

#### 1) TO-220AB(MP-25)

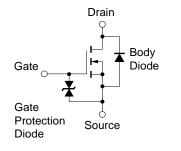


#### 3) TO-263 (MP-25ZJ)



Remark

#### **EQUIVALENT CIRCUIT**

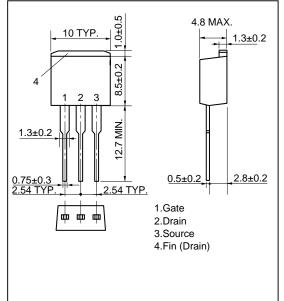


**Note** This package is produced only in Japan.

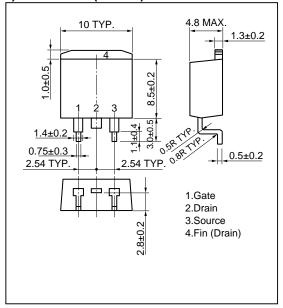
The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.



#### 2) TO-262(MP-25 Fin Cut)



4) TO-220SMD(MP-25Z)<sup>Note</sup>



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